

---

# HM5164405A Series

# HM5165405A Series

64M EDO DRAM (16-Mword  $\times$  4-bit)  
8k refresh/4k refresh

# HITACHI

ADE-203-459B (Z)  
Rev. 2.0  
Oct. 28, 1997

---

## Description

The Hitachi HM5164405A Series, HM5165405A Series are CMOS dynamic RAMs organized 16,777,216-word  $\times$  4-bit. They employ the most advanced CMOS technology for high performance and low power. The HM5164405A Series, HM5165405A Series offer Extended Data Out (EDO) Page Mode as a high speed access mode. They have the package variations of standard 400-mil 32-pin plastic SOJ and standard 400-mil 32-pin plastic TSOPII.

## Features

- Single 3.3 V supply: 3.3 V  $\pm$  0.3 V / -0.15 V (HM5165405A-5R)  
3.3 V  $\pm$  0.3 V (HM5164405A Series, HM5165405A/AL-6/7)
- Access time: 50 ns/60 ns/70 ns (max)
- Power dissipation
  - Active mode : TBD/396 mW/342 mW (max) (HM5164405A Series)  
: 684 mW/576 mW/504 mW (max) (HM5165405A Series)
  - Standby mode : 7.2 mW (max)  
: 1.08 mW (L-version)
- EDO page mode capability
- Refresh cycle
  - $\overline{\text{RAS}}$ -only refresh
    - 8192 cycles /64 ms (HM5164405A)  
/128 ms (HM5164405AL) (L-version)
    - 4096 cycles /64 ms (HM5165405A)  
/128 ms (HM5165405AL) (L-version)
  - CBR/Hidden refresh
    - 4096 cycles /64 ms (HM5164405A, HM5165405A)  
/128 ms (HM5164405AL, HM5165405AL) (L-version)
- 4 variations of refresh
  - $\overline{\text{RAS}}$ -only refresh

---

## HM5164405A Series, HM5165405A Series

---

- $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$  refresh
- Hidden refresh
- Self refresh (L-version)
- Battery backup operation (L-version)

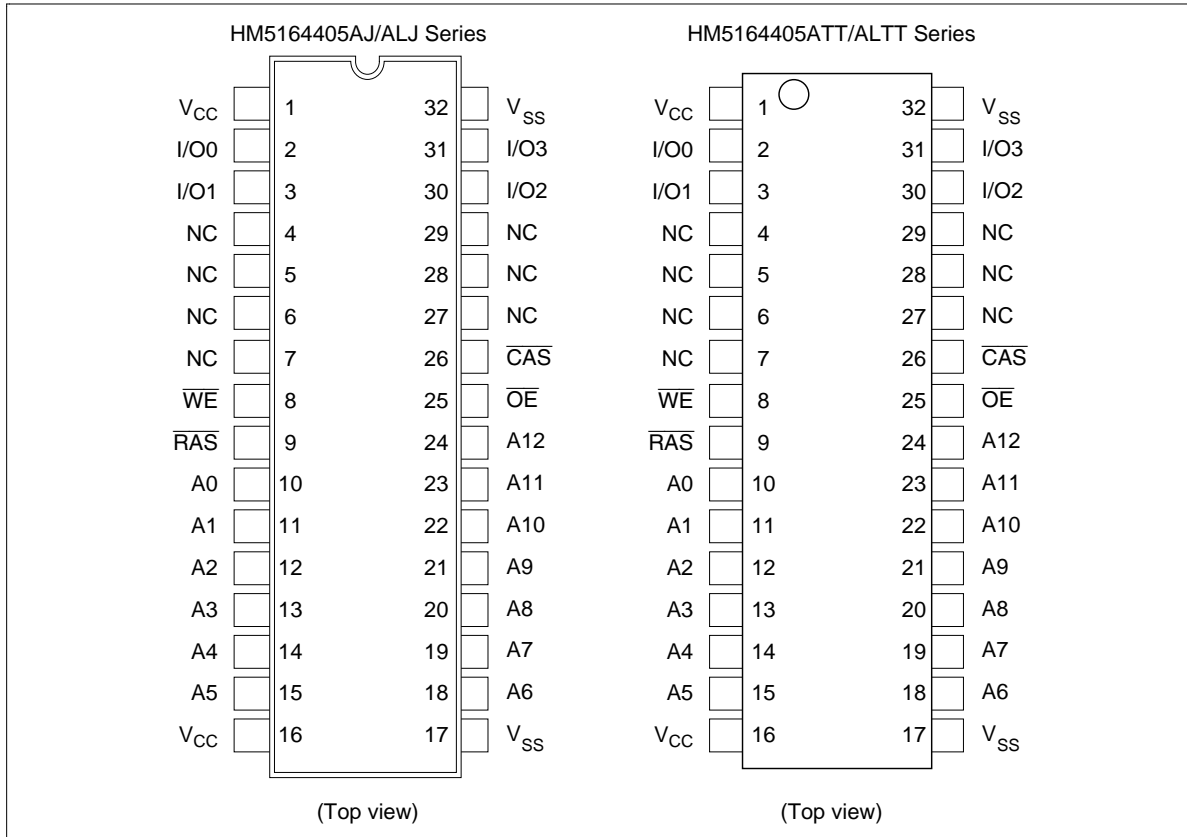
### Ordering Information

Type No.	Access time	Package
HM5164405AJ-6	60 ns	400-mil 32-pin plastic SOJ (CP-32DC)
HM5164405AJ-7	70 ns	
HM5164405ALJ-6	60 ns	
HM5164405ALJ-7	70 ns	
HM5165405AJ-6	60 ns	
HM5165405AJ-7	70 ns	
HM5165405ALJ-6	60 ns	
HM5165405ALJ-7	70 ns	
HM5164405ATT-6	60 ns	400-mil 32-pin plastic TSOP II (TTP-32DC)
HM5164405ATT-7	70 ns	
HM5164405ALTT-6	60 ns	
HM5164405ALTT-7	70 ns	
HM5165405ATT-5R	50 ns	
HM5165405ATT-6	60 ns	
HM5165405ATT-7	70 ns	
HM5165405ALTT-6	60 ns	
HM5165405ALTT-7	70 ns	

---

## HM5164405A Series, HM5165405A Series

### Pin Arrangement

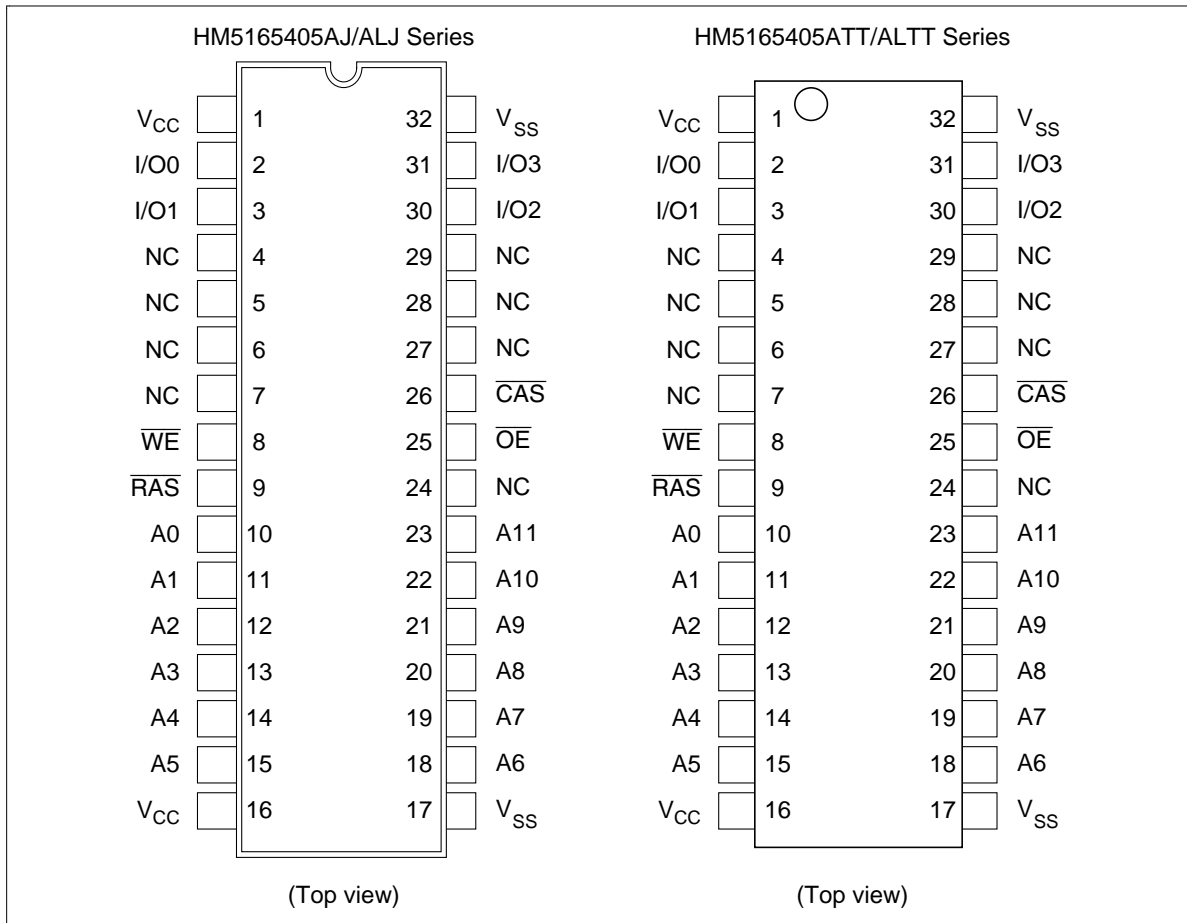


### Pin Description

Pin name	Function
A0 to A12	Address input <ul style="list-style-type: none"> <li>• Row/Refresh address A0 to A12</li> <li>• Column address A0 to A10</li> </ul>
I/O0 to I/O3	Data input/Data output
$\overline{\text{RAS}}$	Row address strobe
$\overline{\text{CAS}}$	Column address strobe
$\overline{\text{WE}}$	Read/Write enable
$\overline{\text{OE}}$	Output enable
V <sub>CC</sub>	Power supply
V <sub>SS</sub>	Ground
NC	No connection

## HM5164405A Series, HM5165405A Series

### Pin Arrangement



### Pin Description

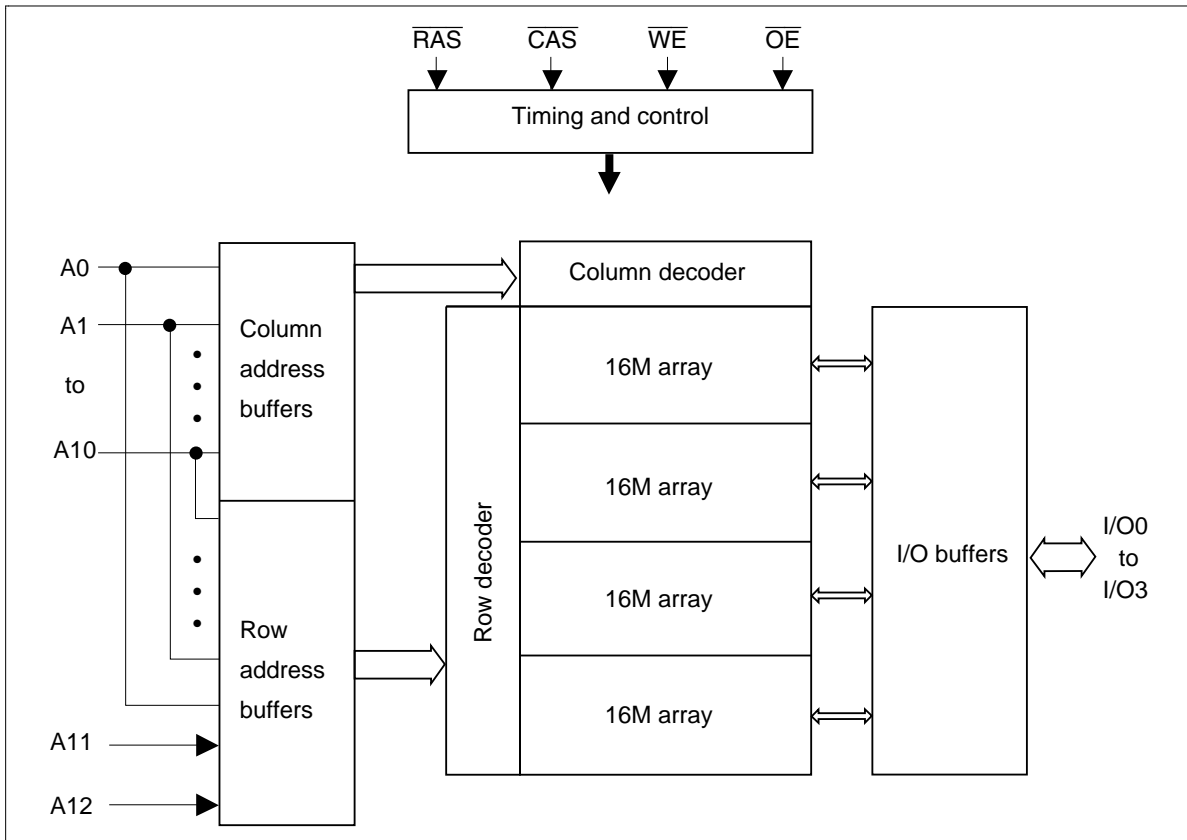
Pin name	Function
A0 to A11	Address input <ul style="list-style-type: none"> <li>• Row/Refresh address A0 to A11</li> <li>• Column address A0 to A11</li> </ul>
I/O0 to I/O3	Data input/Data output
RAS	Row address strobe
CAS	Column address strobe
WE	Read/Write enable
OE	Output enable
V <sub>CC</sub>	Power supply
V <sub>SS</sub>	Ground
NC	No connection

---

## HM5164405A Series, HM5165405A Series

---

### Block Diagram (HM5164405A Series)

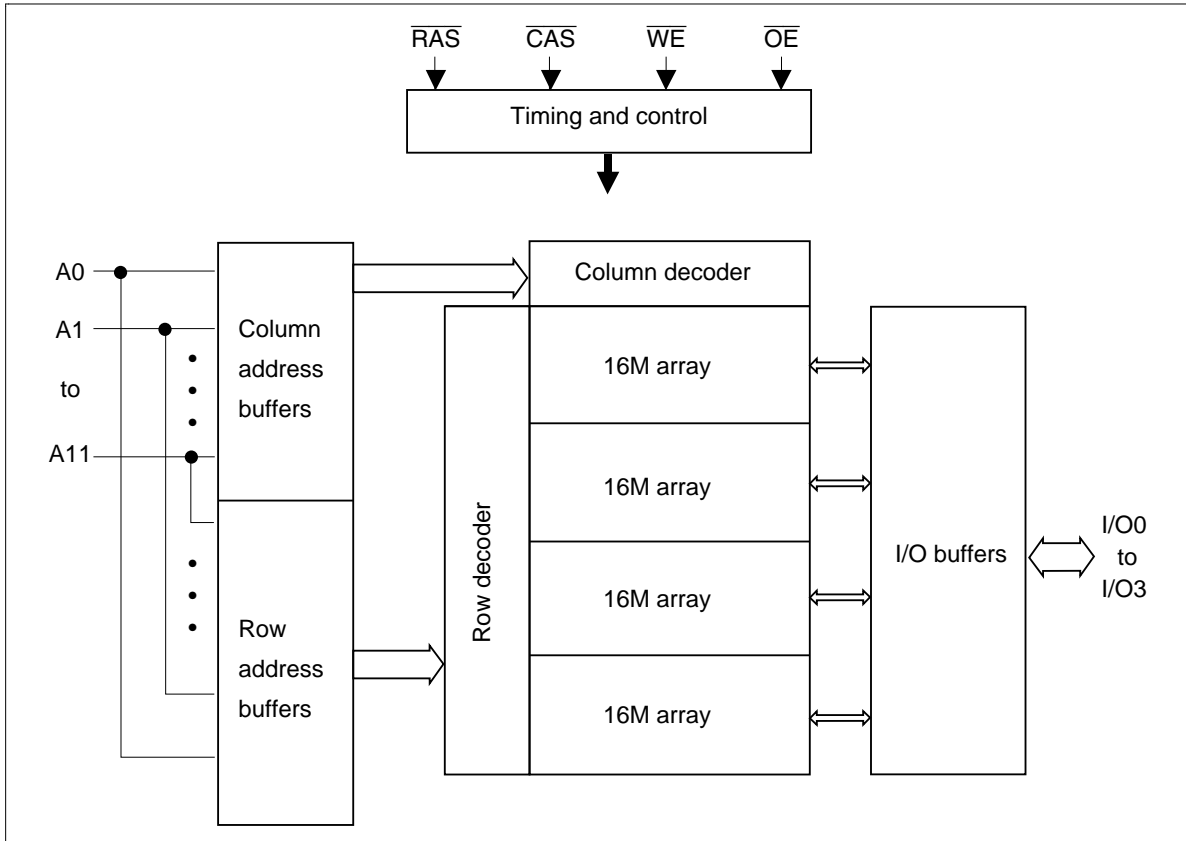


---

## HM5164405A Series, HM5165405A Series

---

**Block Diagram** (HM5165405A Series)



## HM5164405A Series, HM5165405A Series

### Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Voltage on any pin relative to $V_{SS}$	$V_T$	$-0.5$ to $V_{CC} + 0.5$ ( $\leq 4.6$ V (max))	V
Supply voltage relative to $V_{SS}$	$V_{CC}$	$-0.5$ to $+4.6$	V
Short circuit output current	$I_{out}$	50	mA
Power dissipation	$P_T$	1.0	W
Operating temperature	$T_{opr}$	0 to $+70$	$^{\circ}C$
Storage temperature	$T_{stg}$	$-55$ to $+125$	$^{\circ}C$

### Recommended DC Operating Conditions ( $T_a = 0$ to $+70^{\circ}C$ )

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Supply voltage	$V_{SS}$	0	0	0	V	2
	$V_{CC}$ (HM5165405A-5R)	3.15	3.3	3.6	V	1, 2
	$V_{CC}$ (HM5164/65405A/AL-6/7)	3.0	3.3	3.6	V	1, 2
Input high voltage	$V_{IH}$	2.0	—	$V_{CC} + 0.3$	V	1
Input low voltage	$V_{IL}$	$-0.3$	—	0.8	V	1

- Note: 1. All voltage referred to  $V_{SS}$ .  
 2. The supply voltage with all  $V_{CC}$  pins must be on the same level. The supply voltage with all  $V_{SS}$  pins must be on the same level.

## HM5164405A Series, HM5165405A Series

### DC Characteristics

( $T_a = 0$  to  $+70^\circ\text{C}$ ,  $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ ,  $V_{SS} = 0 \text{ V}$ ) (HM5164405A Series)

Parameter	Symbol	HM5164405A						Unit	Test conditions
		-5R		-6		-7			
		Min	Max	Min	Max	Min	Max		
Operating current <sup>*1, *2</sup>	$I_{CC1}$	—	TBD	—	110	—	95	mA	$t_{RC} = \text{min}$
Standby current	$I_{CC2}$	—	TBD	—	2	—	2	mA	TTL interface $\overline{\text{RAS}}, \overline{\text{CAS}} = V_{IH}$ Dout = High-Z
		—	TBD	—	1	—	1	mA	CMOS interface $\overline{\text{RAS}}, \overline{\text{CAS}} \geq V_{CC} - 0.2 \text{ V}$ Dout = High-Z
Standby current (L-version)	$I_{CC2}$	—	TBD	—	300	—	300	$\mu\text{A}$	CMOS interface $\overline{\text{RAS}}, \overline{\text{CAS}} \geq V_{CC} - 0.2 \text{ V}$ Dout = High-Z
$\overline{\text{RAS}}$ -only refresh current <sup>*2</sup>	$I_{CC3}$	—	TBD	—	110	—	95	mA	$t_{RC} = \text{min}$
Standby current <sup>*1</sup>	$I_{CC5}$	—	TBD	—	5	—	5	mA	$\overline{\text{RAS}} = V_{IH}$ , $\overline{\text{CAS}} = V_{IL}$ Dout = enable
$\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh current	$I_{CC6}$	—	TBD	—	140	—	120	mA	$t_{RC} = \text{min}$
EDO page mode current <sup>*1, *3</sup>	$I_{CC7}$	—	TBD	—	105	—	90	mA	$t_{HPC} = \text{min}$
Battery backup current <sup>*4</sup> (Standby with CBR refresh) (L-version)	$I_{CC10}$	—	TBD	—	650	—	650	$\mu\text{A}$	CMOS interface Dout = High-Z, CBR refresh: $t_{RC} = 31.3 \mu\text{s}$ $t_{RAS} \leq 0.3 \mu\text{s}$
Self refresh mode current (L-version)	$I_{CC11}$	—	TBD	—	500	—	500	$\mu\text{A}$	CMOS interface $\overline{\text{RAS}}, \overline{\text{CAS}} \leq 0.2 \text{ V}$ Dout = High-Z
Input leakage current	$I_{LI}$	TBD	TBD	-10	10	-10	10	$\mu\text{A}$	$0 \text{ V} \leq V_{in} \leq V_{CC} + 0.3 \text{ V}$
Output leakage current	$I_{LO}$	TBD	TBD	-10	10	-10	10	$\mu\text{A}$	$0 \text{ V} \leq V_{out} \leq V_{CC}$ Dout = disable
Output high voltage	$V_{OH}$	TBD	TBD	2.4	$V_{CC}$	2.4	$V_{CC}$	V	High Iout = -2 mA
Output low voltage	$V_{OL}$	TBD	TBD	0	0.4	0	0.4	V	Low Iout = 2 mA

Notes : 1.  $I_{CC}$  depends on output load condition when the device is selected.  $I_{CC}$  max is specified at the output open condition.

2. Address can be changed once or less while  $\overline{\text{RAS}} = V_{IL}$ .

3. Address can be changed once or less within one page mode cycle  $t_{HPC}$ .

4.  $V_{IH} \geq V_{CC} - 0.2 \text{ V}$ ,  $0 \text{ V} \leq V_{IL} \leq 0.2 \text{ V}$ .



## HM5164405A Series, HM5165405A Series

### DC Characteristics

(Ta = 0 to +70°C, V<sub>CC</sub> = 3.3 V +0.3 V/-0.15 V, V<sub>SS</sub> = 0 V) (HM5165405A-5R)

(Ta = 0 to +70°C, V<sub>CC</sub> = 3.3 V ± 0.3 V, V<sub>SS</sub> = 0 V) (HM5165405A/AL-6/7)

Parameter	Symbol	HM5165405A						Unit	Test conditions
		-5R		-6		-7			
		Min	Max	Min	Max	Min	Max		
Operating current* <sup>1, *2</sup>	I <sub>CC1</sub>	—	190	—	160	—	140	mA	t <sub>RC</sub> = min
Standby current	I <sub>CC2</sub>	—	2	—	2	—	2	mA	TTL interface R <sub>AS</sub> , C <sub>AS</sub> = V <sub>IH</sub> Dout = High-Z
		—	1	—	1	—	1	mA	CMOS interface R <sub>AS</sub> , C <sub>AS</sub> ≥ V <sub>CC</sub> - 0.2 V Dout = High-Z
Standby current (L-version)	I <sub>CC2</sub>	—	TBD	—	300	—	300	μA	CMOS interface R <sub>AS</sub> , C <sub>AS</sub> ≥ V <sub>CC</sub> - 0.2 V Dout = High-Z
R <sub>AS</sub> -only refresh current* <sup>2</sup>	I <sub>CC3</sub>	—	190	—	160	—	140	mA	t <sub>RC</sub> = min
Standby current* <sup>1</sup>	I <sub>CC5</sub>	—	5	—	5	—	5	mA	R <sub>AS</sub> = V <sub>IH</sub> , C <sub>AS</sub> = V <sub>IL</sub> Dout = enable
C <sub>AS</sub> -before-R <sub>AS</sub> refresh current	I <sub>CC6</sub>	—	170	—	140	—	120	mA	t <sub>RC</sub> = min
EDO page mode current* <sup>1, *3</sup>	I <sub>CC7</sub>	—	145	—	120	—	105	mA	t <sub>HPC</sub> = min
Battery backup current* <sup>4</sup> (Standby with CBR refresh) (L-version)	I <sub>CC10</sub>	—	TBD	—	650	—	650	μA	CMOS interface Dout = High-Z, CBR refresh: t <sub>RC</sub> = 31.3 μs t <sub>RAS</sub> ≤ 0.3 μs
Self refresh mode current (L-version)	I <sub>CC11</sub>	—	TBD	—	500	—	500	μA	CMOS interface R <sub>AS</sub> , C <sub>AS</sub> ≤ 0.2 V Dout = High-Z
Input leakage current	I <sub>LI</sub>	-10	10	-10	10	-10	10	μA	0 V ≤ Vin ≤ V <sub>CC</sub> + 0.3 V
Output leakage current	I <sub>LO</sub>	-10	10	-10	10	-10	10	μA	0 V ≤ Vout ≤ V <sub>CC</sub> Dout = disable
Output high voltage	V <sub>OH</sub>	2.4	V <sub>CC</sub>	2.4	V <sub>CC</sub>	2.4	V <sub>CC</sub>	V	High Iout = -2 mA
Output low voltage	V <sub>OL</sub>	0	0.4	0	0.4	0	0.4	V	Low Iout = 2 mA

Notes : 1. I<sub>CC</sub> depends on output load condition when the device is selected. I<sub>CC</sub> max is specified at the output open condition.

2. Address can be changed once or less while R<sub>AS</sub> = V<sub>IL</sub>.

3. Address can be changed once or less within one page mode cycle t<sub>HPC</sub>.

4. V<sub>IH</sub> ≥ V<sub>CC</sub> - 0.2 V, 0 V ≤ V<sub>IL</sub> ≤ 0.2 V.

---

## HM5164405A Series, HM5165405A Series

---

### Capacitance

(Ta = 25°C, V<sub>CC</sub> = 3.3 V +0.3 V/-0.15 V) (HM5165405A-5R)

(Ta = 25°C, V<sub>CC</sub> = 3.3 V ± 0.3 V) (HM5164405A Series, HM5165405A/AL-6/7)

Parameter	Symbol	Typ	Max	Unit	Notes
Input capacitance (Address)	C <sub>I1</sub>	—	5	pF	1
Input capacitance (Clocks)	C <sub>I2</sub>	—	7	pF	1
Output capacitance (Data-in, Data-out)	C <sub>I/O</sub>	—	7	pF	1, 2

Notes : 1. Capacitance measured with Boonton Meter or effective capacitance measuring method.

2.  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}} = V_{\text{IH}}$  to disable Dout.

## HM5164405A Series, HM5165405A Series

### AC Characteristics\*<sup>1</sup>, \*<sup>2</sup>, \*<sup>17</sup>

(Ta = 0 to +70°C, V<sub>CC</sub> = 3.3 V +0.3 V/-0.15 V, V<sub>SS</sub> = 0 V) (HM5165405A-5R)

(Ta = 0 to +70°C, V<sub>CC</sub> = 3.3 V ± 0.3 V, V<sub>SS</sub> = 0 V) (HM5164405A Series,  
HM5165405A/AL-6/7)

### Test Conditions

- Input rise and fall time: 2 ns
- Input levels: 0 V, 3.0 V
- Input timing reference levels: 0.8 V, 2.0 V
- Output timing reference levels: 0.8 V, 2.0 V
- Output load: 1 TTL gate + C<sub>L</sub> (50 pF) (Including scope and jig) (HM5165405A-5R)  
1 TTL gate + C<sub>L</sub> (100 pF) (Including scope and jig) (HM5164405A Series,  
HM5165405A/AL-6/7)

### Read, Write, Read-Modify-Write and Refresh Cycles (Common parameters)

		HM5164405A/HM5165405A							
		-5R		-6		-7			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
Random read or write cycle time	t <sub>RC</sub>	84	—	104	—	124	—	ns	
$\overline{\text{RAS}}$ precharge time	t <sub>RP</sub>	30	—	40	—	50	—	ns	
$\overline{\text{CAS}}$ precharge time	t <sub>CP</sub>	8	—	10	—	13	—	ns	
$\overline{\text{RAS}}$ pulse width	t <sub>RAS</sub>	50	10000	60	10000	70	10000	ns	
$\overline{\text{CAS}}$ pulse width	t <sub>CAS</sub>	8	10000	10	10000	13	10000	ns	
Row address setup time	t <sub>ASR</sub>	0	—	0	—	0	—	ns	
Row address hold time	t <sub>RAH</sub>	8	—	10	—	10	—	ns	
Column address setup time	t <sub>ASC</sub>	0	—	0	—	0	—	ns	
Column address hold time	t <sub>CAH</sub>	8	—	10	—	13	—	ns	
$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ delay time	t <sub>RCD</sub>	12	37	20	45	20	52	ns	3
$\overline{\text{RAS}}$ to column address delay time	t <sub>RAD</sub>	10	25	14	30	14	35	ns	4
$\overline{\text{RAS}}$ hold time	t <sub>RSH</sub>	13	—	15	—	18	—	ns	
$\overline{\text{CAS}}$ hold time	t <sub>CSH</sub>	40	—	48	—	58	—	ns	21
$\overline{\text{CAS}}$ to $\overline{\text{RAS}}$ precharge time	t <sub>CRP</sub>	5	—	5	—	5	—	ns	
$\overline{\text{OE}}$ to Din delay time	t <sub>OED</sub>	13	—	15	—	18	—	ns	5
$\overline{\text{OE}}$ delay time from Din	t <sub>DZO</sub>	0	—	0	—	0	—	ns	6
$\overline{\text{CAS}}$ delay time from Din	t <sub>DZC</sub>	0	—	0	—	0	—	ns	6
Transition time (rise and fall)	t <sub>T</sub>	2	50	2	50	2	50	ns	7

## HM5164405A Series, HM5165405A Series

### Read Cycle

Parameter	Symbol	HM5164405A/HM5165405A						Unit	Notes
		-5R		-6		-7			
		Min	Max	Min	Max	Min	Max		
Access time from $\overline{\text{RAS}}$	$t_{\text{RAC}}$	—	50	—	60	—	70	ns	8, 9
Access time from $\overline{\text{CAS}}$	$t_{\text{CAC}}$	—	13	—	15	—	18	ns	9, 10, 16
Access time from address	$t_{\text{AA}}$	—	25	—	30	—	35	ns	9, 11, 16
Access time from $\overline{\text{OE}}$	$t_{\text{OEA}}$	—	13	—	15	—	18	ns	9
Read command setup time	$t_{\text{RCS}}$	0	—	0	—	0	—	ns	
Read command hold time to $\overline{\text{CAS}}$	$t_{\text{RCH}}$	0	—	0	—	0	—	ns	12
Read command hold time from $\overline{\text{RAS}}$	$t_{\text{RCHR}}$	50	—	60	—	70	—	ns	
Read command hold time to $\overline{\text{RAS}}$	$t_{\text{RRH}}$	5	—	0	—	0	—	ns	12
Column address to $\overline{\text{RAS}}$ lead time	$t_{\text{RAL}}$	25	—	30	—	35	—	ns	
Column address to $\overline{\text{CAS}}$ lead time	$t_{\text{CAL}}$	15	—	18	—	23	—	ns	
$\overline{\text{CAS}}$ to output in low-Z	$t_{\text{CLZ}}$	0	—	0	—	0	—	ns	
Output data hold time	$t_{\text{OH}}$	3	—	3	—	3	—	ns	20
Output data hold time from $\overline{\text{OE}}$	$t_{\text{OHO}}$	3	—	3	—	3	—	ns	
Output buffer turn-off time	$t_{\text{OFF}}$	—	15	—	15	—	15	ns	13, 20
Output buffer turn-off to $\overline{\text{OE}}$	$t_{\text{OEZ}}$	—	13	—	15	—	15	ns	13
$\overline{\text{CAS}}$ to Din delay time	$t_{\text{CDD}}$	13	—	15	—	18	—	ns	5
Output data hold time from $\overline{\text{RAS}}$	$t_{\text{OHR}}$	3	—	3	—	3	—	ns	20
Output buffer turn-off to $\overline{\text{RAS}}$	$t_{\text{OFR}}$	—	13	—	15	—	15	ns	13, 20
Output buffer turn-off to $\overline{\text{WE}}$	$t_{\text{WEZ}}$	—	13	—	15	—	15	ns	13
$\overline{\text{WE}}$ to Din delay time	$t_{\text{WED}}$	13	—	15	—	18	—	ns	
$\overline{\text{RAS}}$ to Din delay time	$t_{\text{RDD}}$	13	—	15	—	18	—	ns	

## HM5164405A Series, HM5165405A Series

### Write Cycle

		HM5164405A/HM5165405A							
		-5R		-6		-7			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
Write command setup time	$t_{WCS}$	0	—	0	—	0	—	ns	14
Write command hold time	$t_{WCH}$	8	—	10	—	13	—	ns	
Write command pulse width	$t_{WCP}$	8	—	10	—	10	—	ns	
Write command to $\overline{RAS}$ lead time	$t_{RWL}$	13	—	15	—	18	—	ns	
Write command to $\overline{CAS}$ lead time	$t_{CWL}$	10	—	10	—	13	—	ns	
Data-in setup time	$t_{DS}$	0	—	0	—	0	—	ns	
Data-in hold time	$t_{DH}$	8	—	10	—	13	—	ns	

### Read-Modify-Write Cycle

		HM5164405A/HM5165405A							
		-5R		-6		-7			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
Read-modify-write cycle time	$t_{RWC}$	111	—	149	—	175	—	ns	
$\overline{RAS}$ to $\overline{WE}$ delay time	$t_{RWD}$	67	—	78	—	91	—	ns	14
$\overline{CAS}$ to $\overline{WE}$ delay time	$t_{CWD}$	30	—	33	—	39	—	ns	14
Column address to $\overline{WE}$ delay time	$t_{AWD}$	42	—	48	—	56	—	ns	14
$\overline{OE}$ hold time from $\overline{WE}$	$t_{OEH}$	13	—	15	—	18	—	ns	

### Refresh Cycle

		HM5164405A/HM5165405A							
		-5R		-6		-7			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
$\overline{CAS}$ setup time (CBR refresh cycle)	$t_{CSR}$	5	—	5	—	5	—	ns	
$\overline{CAS}$ hold time (CBR refresh cycle)	$t_{CHR}$	8	—	10	—	10	—	ns	
$\overline{WE}$ setup time (CBR refresh cycle)	$t_{WRP}$	0	—	0	—	0	—	ns	
$\overline{WE}$ hold time (CBR refresh cycle)	$t_{WRH}$	10	—	10	—	10	—	ns	
$\overline{RAS}$ precharge to $\overline{CAS}$ hold time	$t_{RPC}$	5	—	0	—	0	—	ns	

## HM5164405A Series, HM5165405A Series

### EDO Page Mode Cycle

Parameter	Symbol	HM5164405A/HM5165405A						Unit	Notes
		-5R		-6		-7			
		Min	Max	Min	Max	Min	Max		
EDO page mode cycle time	$t_{HPC}$	20	—	25	—	30	—	ns	19
EDO page mode $\overline{RAS}$ pulse width	$t_{RASP}$	—	100000	—	100000	—	100000	ns	15
Access time from $\overline{CAS}$ precharge	$t_{CPA}$	—	28	—	35	—	40	ns	9, 16
$\overline{RAS}$ hold time from $\overline{CAS}$ precharge	$t_{CPRH}$	28	—	35	—	40	—	ns	
Output data hold time from $\overline{CAS}$ low	$t_{DOH}$	3	—	3	—	3	—	ns	9
$\overline{CAS}$ hold time referred $\overline{OE}$	$t_{COL}$	8	—	10	—	13	—	ns	
$\overline{CAS}$ to $\overline{OE}$ setup time	$t_{COP}$	8	—	10	—	10	—	ns	
Read command hold time from $\overline{CAS}$ precharge	$t_{RCHC}$	28	—	35	—	40	—	ns	
Write pulse width during $\overline{CAS}$ precharge	$t_{WPE}$	8	—	10	—	10	—	ns	
$\overline{OE}$ precharge time	$t_{OEP}$	8	—	10	—	10	—	ns	

### EDO Page Mode Read-Modify-Write Cycle

Parameter	Symbol	HM5164405A/HM5165405A						Unit	Notes
		-5R		-6		-7			
		Min	Max	Min	Max	Min	Max		
EDO page mode read- modify-write cycle time	$t_{HPRWC}$	57	—	68	—	79	—	ns	
$\overline{WE}$ delay time from $\overline{CAS}$ precharge	$t_{CPW}$	45	—	54	—	62	—	ns	14

### Refresh (HM5164405A Series)

Parameter	Symbol	Max	Unit	Notes
Refresh period	$t_{REF}$	64	ms	8192 cycles
Refresh period (L-version)	$t_{REF}$	128	ms	8192 cycles

### Refresh (HM5165405A Series)

Parameter	Symbol	Max	Unit	Notes
Refresh period	$t_{REF}$	64	ms	4096 cycles
Refresh period (L-version)	$t_{REF}$	128	ms	4096 cycles

## HM5164405A Series, HM5165405A Series

### Self Refresh Mode (L-version)

Parameter	Symbol	HM5164405AL/HM5165405AL						Unit	Notes
		-5R		-6		-7			
		Min	Max	Min	Max	Min	Max		
RAS pulse width (self refresh)	$t_{RASS}$	TBD	—	100	—	100	—	$\mu$ s	
RAS precharge time (self refresh)	$t_{RPS}$	TBD	—	110	—	130	—	ns	
CAS hold time (self refresh)	$t_{CHS}$	TBD	—	-50	—	-50	—	ns	

- Notes:
- AC measurements assume  $t_r = 2$  ns.
  - An initial pause of 200  $\mu$ s is required after power up followed by a minimum of eight initialization cycles (any combination of cycles containing  $\overline{RAS}$ -only refresh or  $\overline{CAS}$ -before- $\overline{RAS}$  refresh).
  - Operation with the  $t_{RCD}$  (max) limit insures that  $t_{RAC}$  (max) can be met,  $t_{RCD}$  (max) is specified as a reference point only; if  $t_{RCD}$  is greater than the specified  $t_{RCD}$  (max) limit, then access time is controlled exclusively by  $t_{CAC}$ .
  - Operation with the  $t_{RAD}$  (max) limit insures that  $t_{RAC}$  (max) can be met,  $t_{RAD}$  (max) is specified as a reference point only; if  $t_{RAD}$  is greater than the specified  $t_{RAD}$  (max) limit, then access time is controlled exclusively by  $t_{AA}$ .
  - Either  $t_{OED}$  or  $t_{CDD}$  must be satisfied.
  - Either  $t_{DZO}$  or  $t_{DZC}$  must be satisfied.
  - $V_{IH}$  (min) and  $V_{IL}$  (max) are reference levels for measuring timing of input signals. Also, transition times are measured between  $V_{IH}$  (min) and  $V_{IL}$  (max).
  - Assumes that  $t_{RCD} \leq t_{RCD}$  (max) and  $t_{RAD} \leq t_{RAD}$  (max). If  $t_{RCD}$  or  $t_{RAD}$  is greater than the maximum recommended value shown in this table,  $t_{RAC}$  exceeds the value shown.
  - Measured with a load circuit equivalent to 1 TTL loads and 50 pF (HM5165405A-5R) and 1 TTL loads and 100 pF (HM5164405A Series, HM5165405A/AL-6/7).
  - Assumes that  $t_{RCD} \geq t_{RCD}$  (max) and  $t_{RCD} + t_{CAC}$  (max)  $\geq t_{RAD} + t_{AA}$  (max).
  - Assumes that  $t_{RAD} \geq t_{RAD}$  (max) and  $t_{RCD} + t_{CAC}$  (max)  $\leq t_{RAD} + t_{AA}$  (max).
  - Either  $t_{RCH}$  or  $t_{RRH}$  must be satisfied for a read cycles.
  - $t_{OFF}$  (max),  $t_{OEZ}$  (max),  $t_{WEZ}$  (max) and  $t_{OFR}$  (max) define the time at which the outputs achieve the open circuit condition and are not referred to output voltage levels.
  - $t_{WCS}$ ,  $t_{RWD}$ ,  $t_{CWD}$ ,  $t_{AWD}$  and  $t_{CPW}$  are not restrictive operating parameters. They are included in the data sheet as electrical characteristics only; if  $t_{WCS} \geq t_{WCS}$  (min), the cycle is an early write cycle and the data out pin will remain open circuit (high impedance) throughout the entire cycle; if  $t_{RWD} \geq t_{RWD}$  (min),  $t_{CWD} \geq t_{CWD}$  (min), and  $t_{AWD} \geq t_{AWD}$  (min), or  $t_{CWD} \geq t_{CWD}$  (min),  $t_{AWD} \geq t_{AWD}$  (min) and  $t_{CPW} \geq t_{CPW}$  (min), the cycle is a read-modify-write and the data output will contain data read from the selected cell; if neither of the above sets of conditions is satisfied, the condition of the data out (at access time) is indeterminate.
  - $t_{RASP}$  defines  $\overline{RAS}$  pulse width in EDO page mode cycles.
  - Access time is determined by the longest among  $t_{AA}$ ,  $t_{CAC}$  and  $t_{CPA}$ .
  - All the  $V_{CC}$  and  $V_{SS}$  pins shall be supplied with the same voltages.
  - In delayed write or read-modify-write cycles,  $\overline{OE}$  must disable output buffer prior to applying data to the device.
  - $t_{HPC}$  (min) can be achieved during a series of EDO page mode write cycles or EDO page mode read cycles. If both write and read operation are mixed in a EDO page mode  $\overline{RAS}$  cycle (EDO page mode mix cycle (1), (2)), minimum value of  $\overline{CAS}$  cycle ( $t_{CAS} + t_{CP} + 2 t_r$ ) becomes greater than the specified  $t_{HPC}$  (min) value. The value of  $\overline{CAS}$  cycle time of mixed EDO page mode is shown in EDO page mode mix cycle (1) and (2).

---

## HM5164405A Series, HM5165405A Series

---

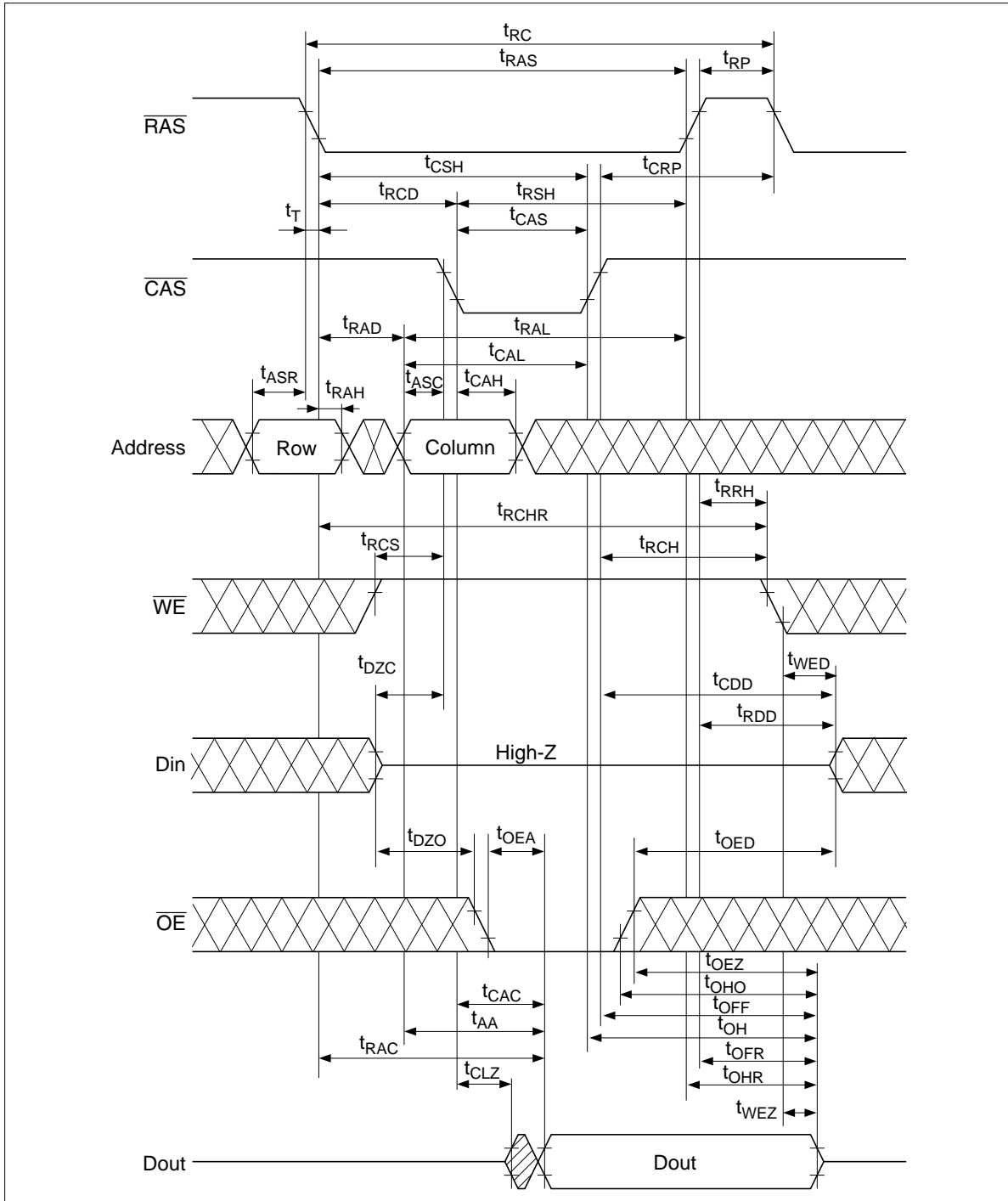
20. Data output turns off and becomes high impedance from later rising edge of  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}}$ . Hold time and turn off time are specified by the timing specifications of later rising edge of  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}}$  between  $t_{\text{OHR}}$  and  $t_{\text{OH}}$  and between  $t_{\text{OFR}}$  and  $t_{\text{OFF}}$ .
21.  $t_{\text{CSH}}$  (min) can be achieved when  $t_{\text{RCD}} \leq t_{\text{CSH}} (\text{min}) - t_{\text{CAS}} (\text{min})$ .
22. Please do not use  $t_{\text{RASS}}$  timing,  $10 \mu\text{s} \leq t_{\text{RASS}} \leq 100 \mu\text{s}$ . During this period, the device is in transition state from normal operation mode to self refresh mode. If  $t_{\text{RASS}} > 100 \mu\text{s}$ , then  $\overline{\text{RAS}}$  precharge time should use  $t_{\text{RPS}}$  instead of  $t_{\text{RP}}$ .
23. CBR burst refresh or 4096 cycles of distributed CBR refresh with  $15.6 \mu\text{s}$  interval should be executed within 64 ms immediately after exiting from and before entering into the self refresh mode.
24. Repetitive self refresh mode without refreshing all memory is not allowed. Once you exit from self refresh mode, all memory cells need to be refreshed before re-entering the self refresh mode again.
25. XXX: H or L (H:  $V_{\text{IH}} (\text{min}) \leq V_{\text{IN}} \leq V_{\text{IH}} (\text{max})$ , L:  $V_{\text{IL}} (\text{min}) \leq V_{\text{IN}} \leq V_{\text{IL}} (\text{max})$ )  
/////: Invalid Dout  
When the address, clock and input pins are not described on timing waveforms, their pins must be applied  $V_{\text{IH}}$  or  $V_{\text{IL}}$ .



# HM5164405A Series, HM5165405A Series

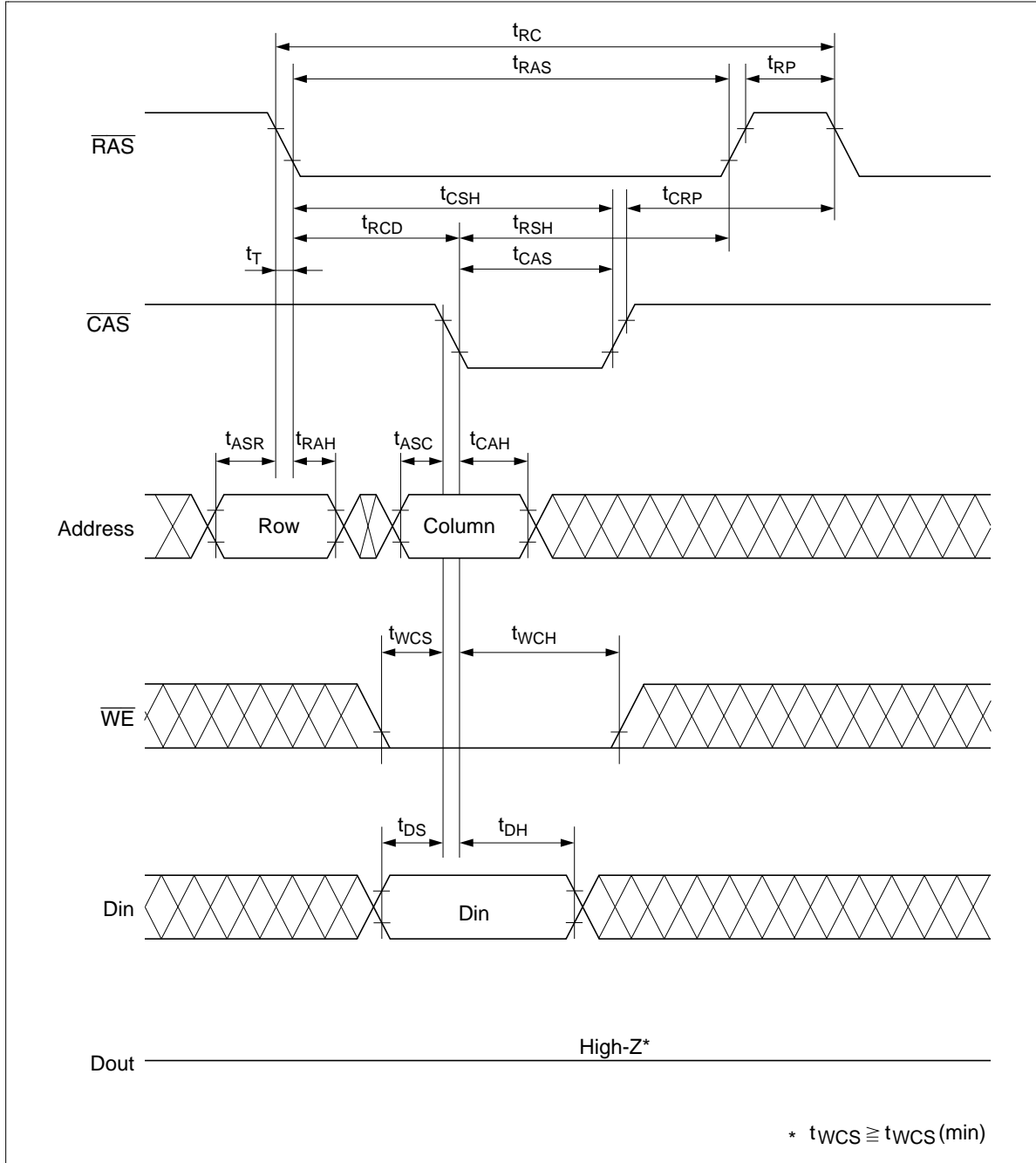
## Timing Waveforms\*25

### Read Cycle



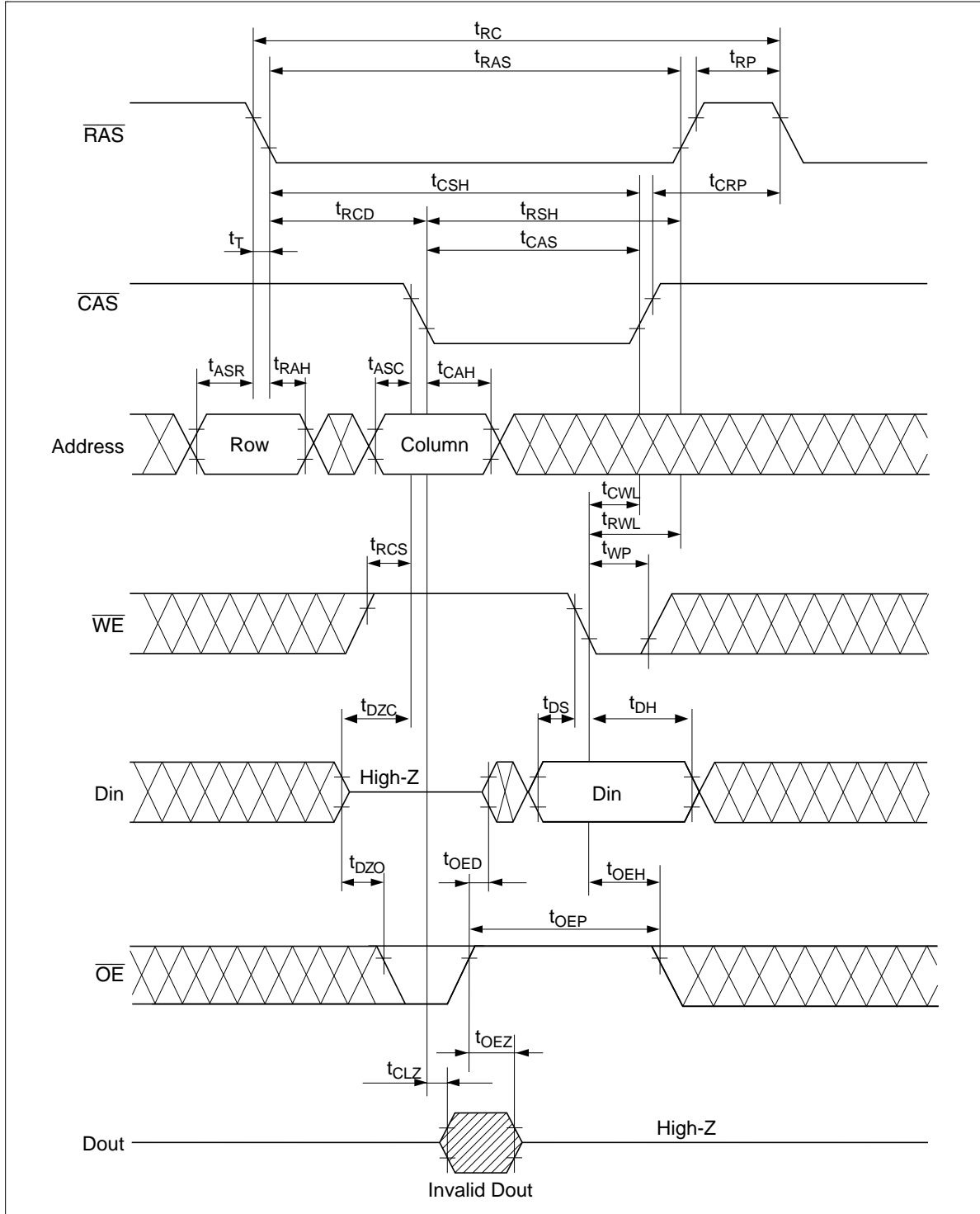
# HM5164405A Series, HM5165405A Series

## Early Write Cycle



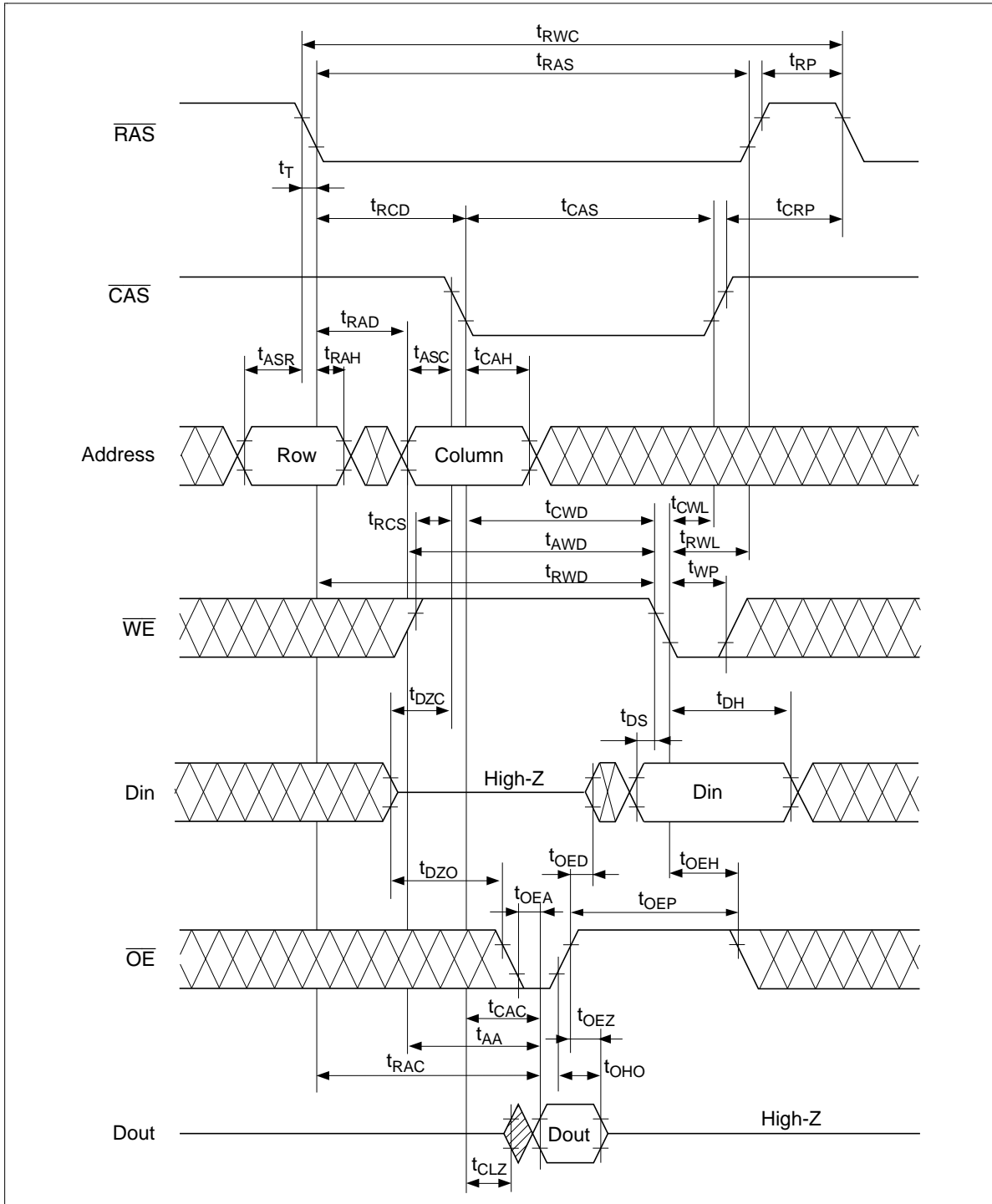
# HM5164405A Series, HM5165405A Series

## Delayed Write Cycle<sup>\*18</sup>



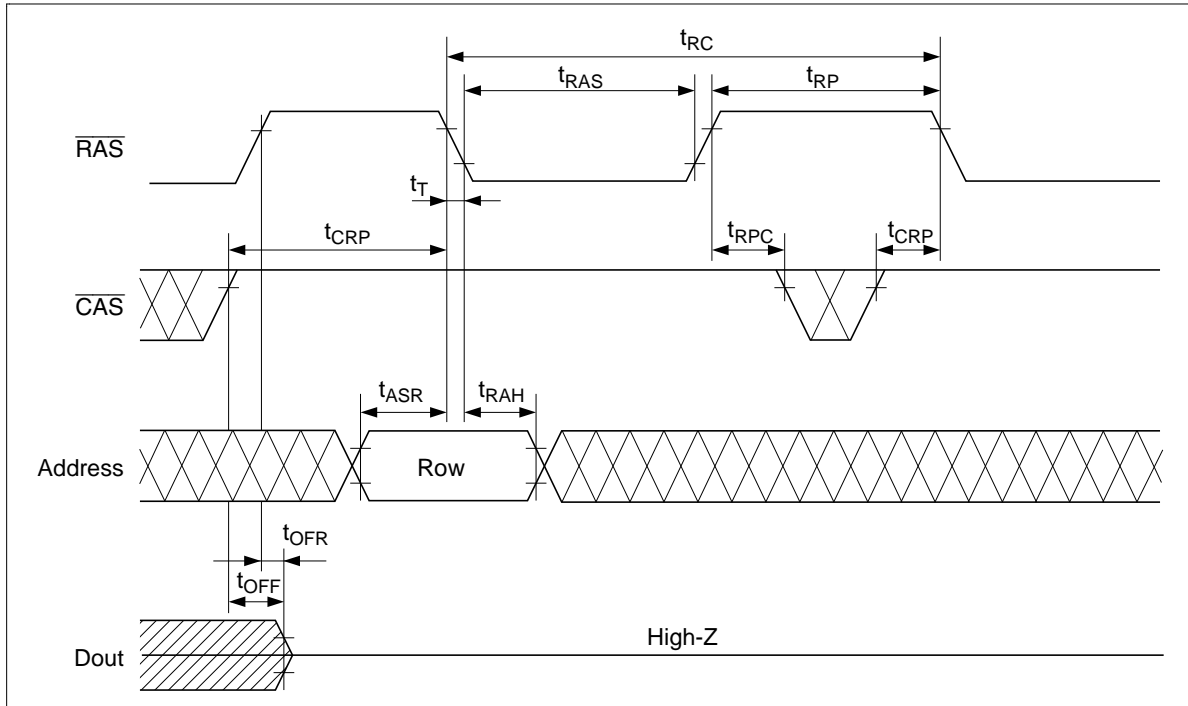
# HM5164405A Series, HM5165405A Series

## Read-Modify-Write Cycle\*18



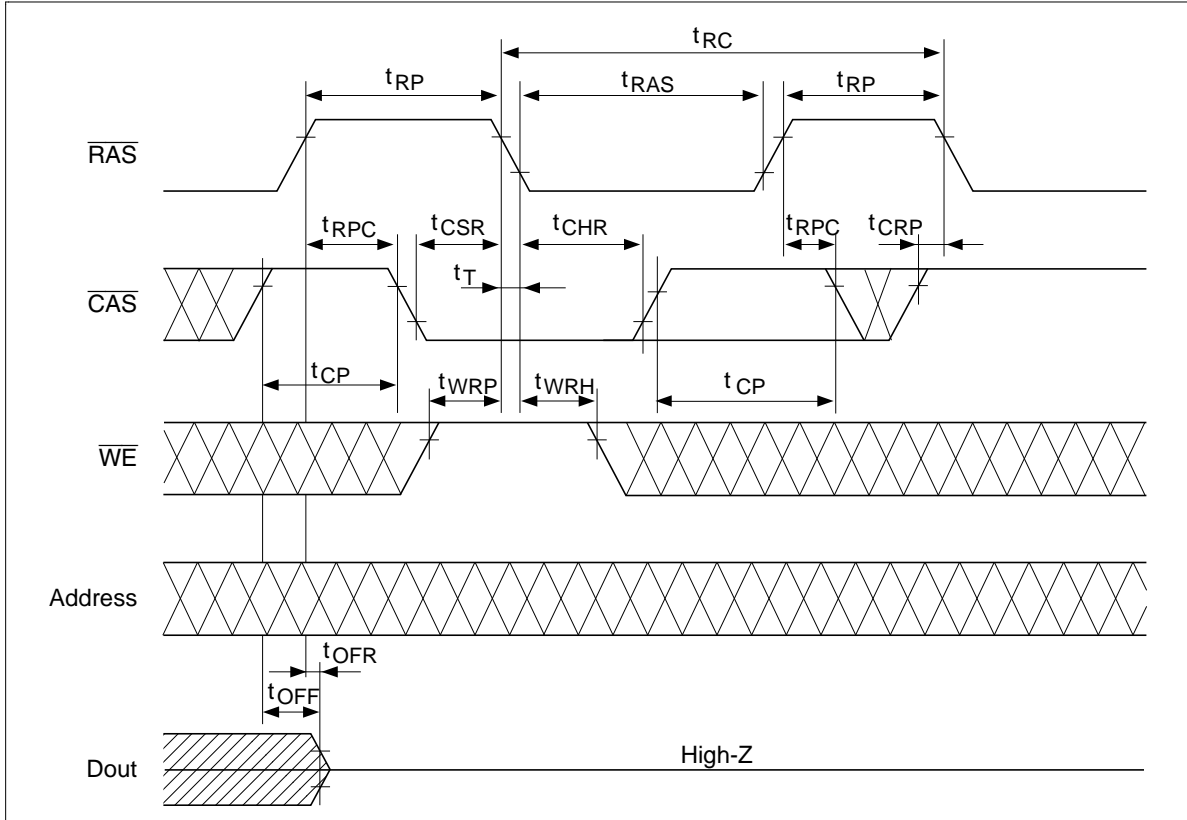
# HM5164405A Series, HM5165405A Series

## $\overline{\text{RAS}}$ -Only Refresh Cycle



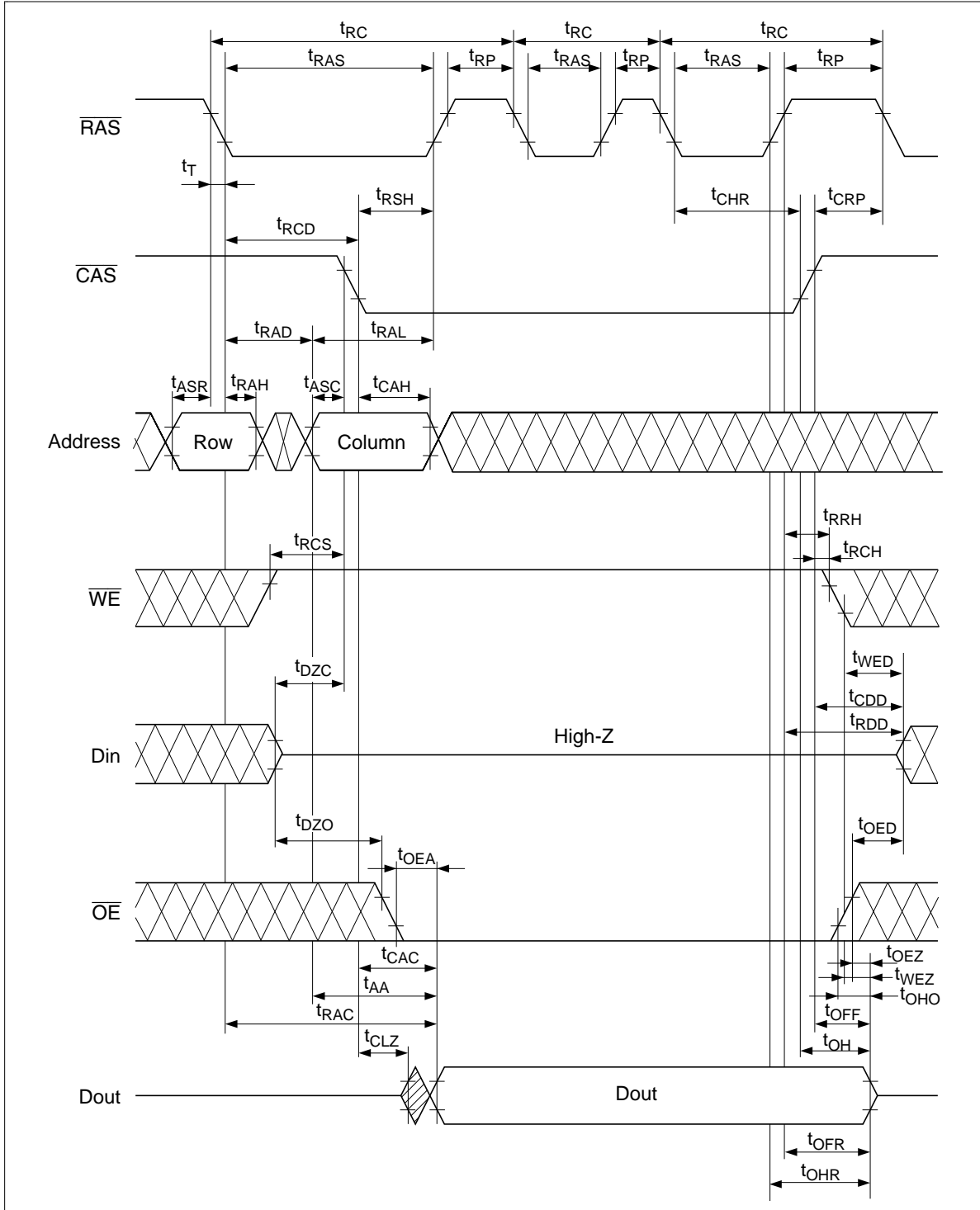
# HM5164405A Series, HM5165405A Series

## $\overline{\text{CAS}}$ -Before- $\overline{\text{RAS}}$ Refresh Cycle



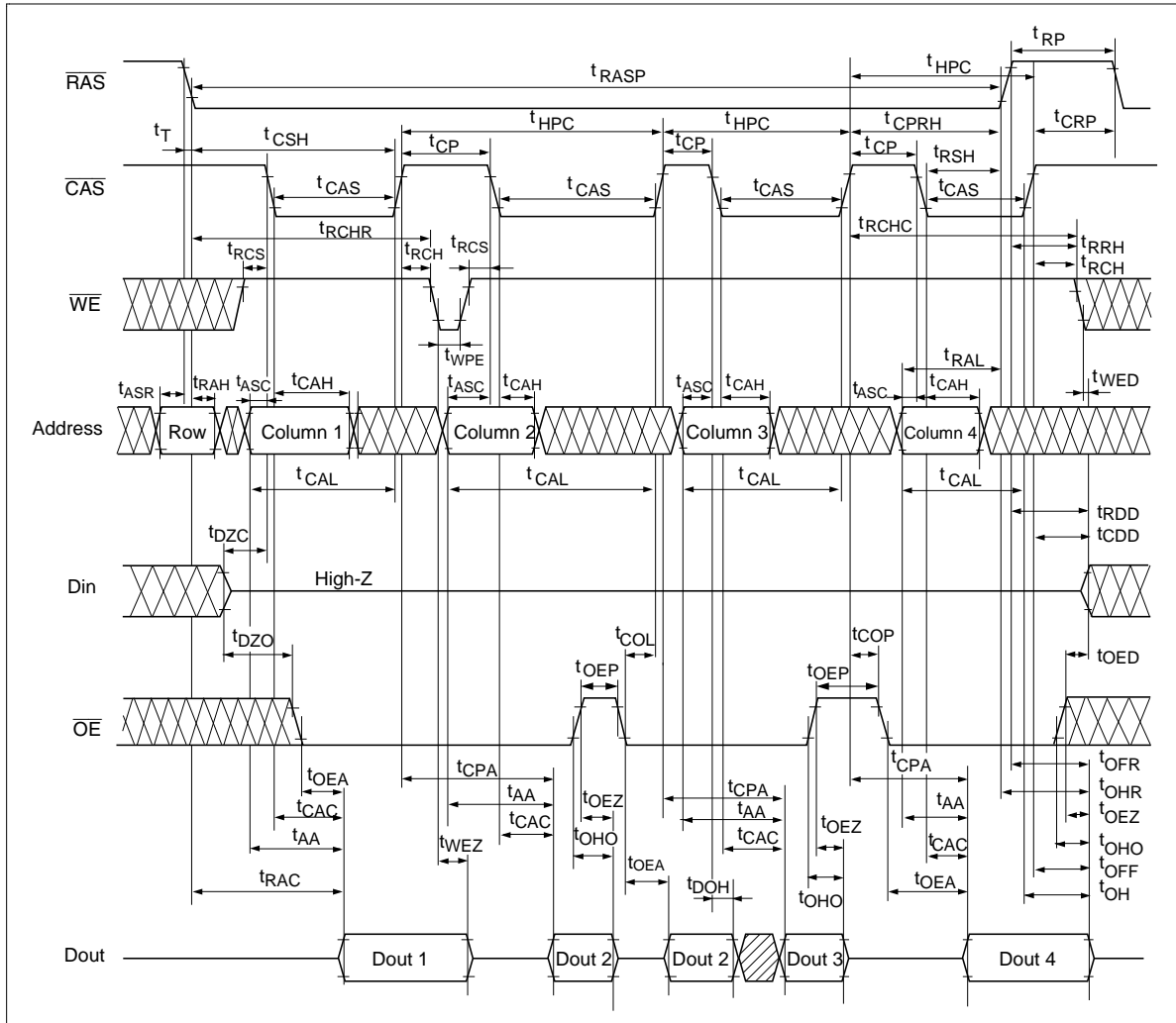
# HM5164405A Series, HM5165405A Series

## Hidden Refresh Cycle



# HM5164405A Series, HM5165405A Series

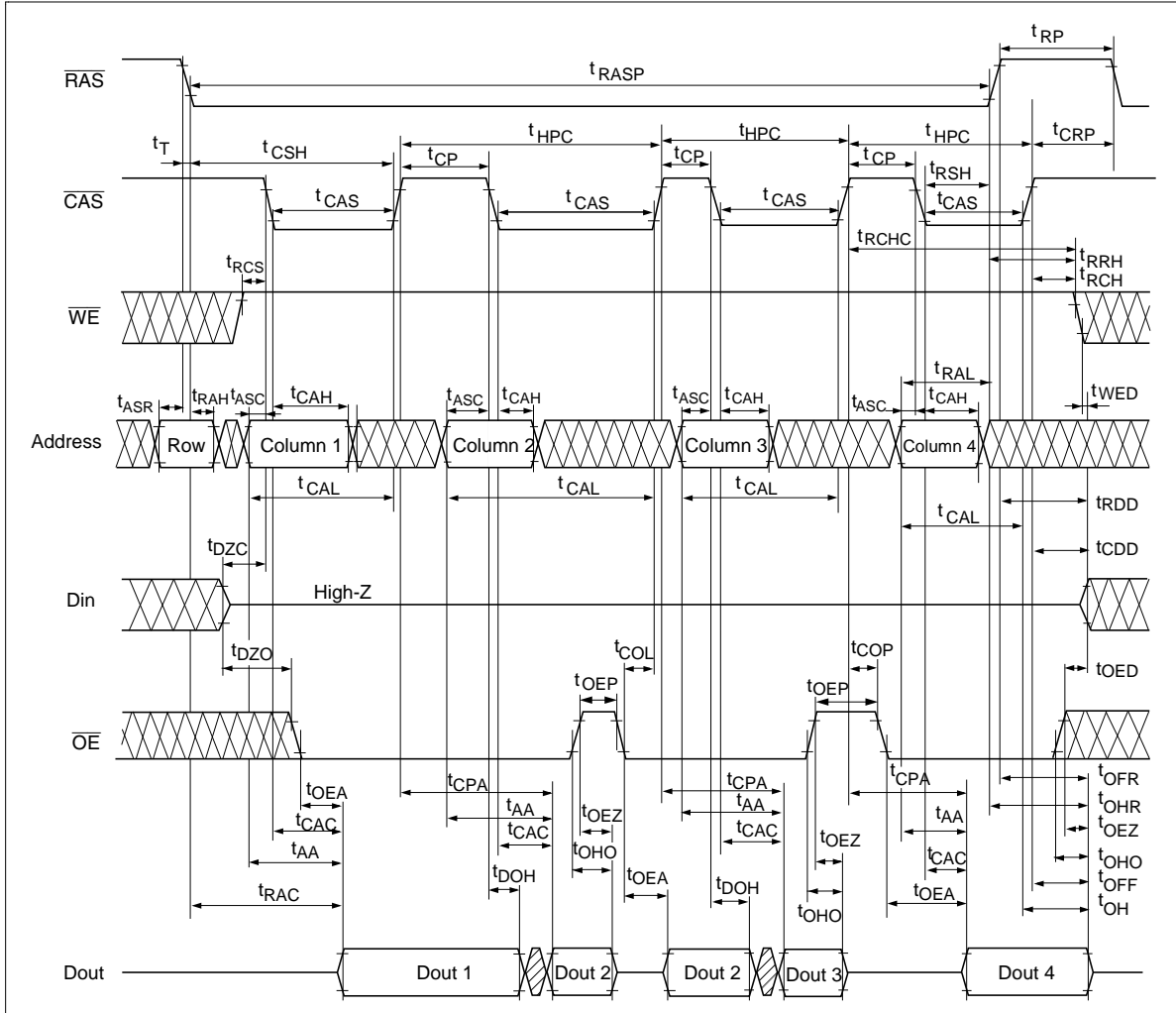
## EDO Page Mode Read Cycle (1)





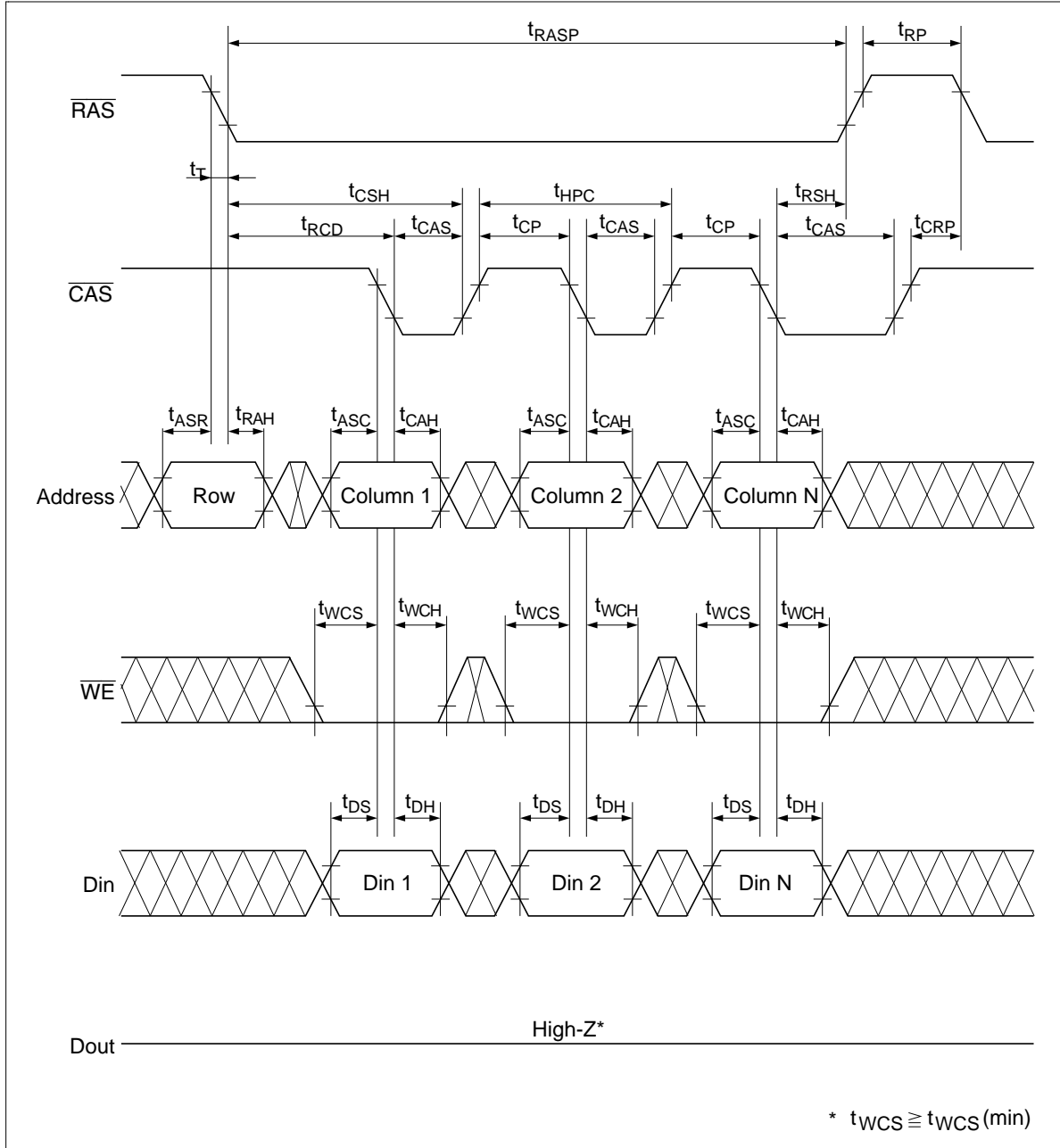
# HM5164405A Series, HM5165405A Series

## EDO Page Mode Read Cycle (2)



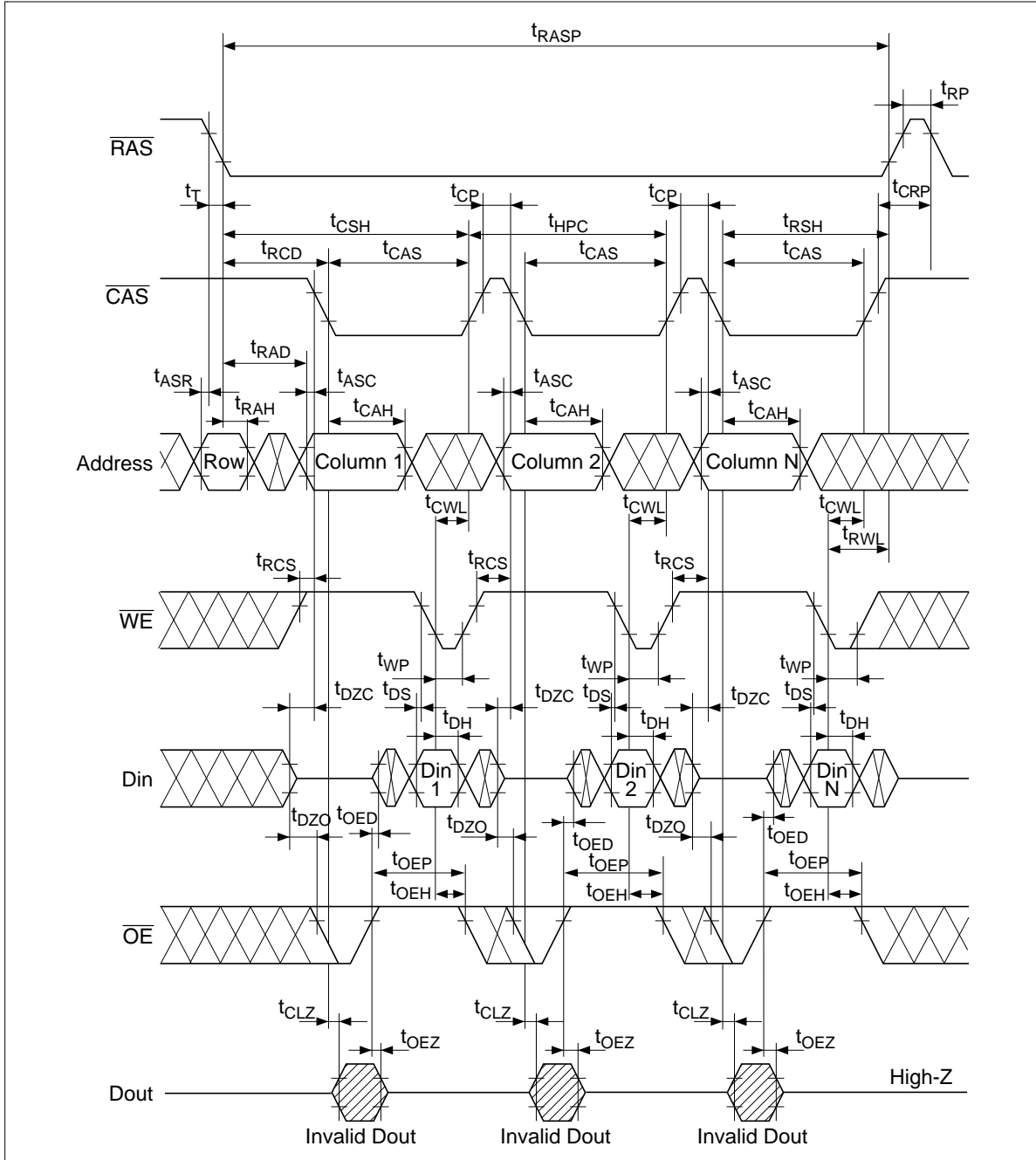
# HM5164405A Series, HM5165405A Series

## EDO Page Mode Early Write Cycle



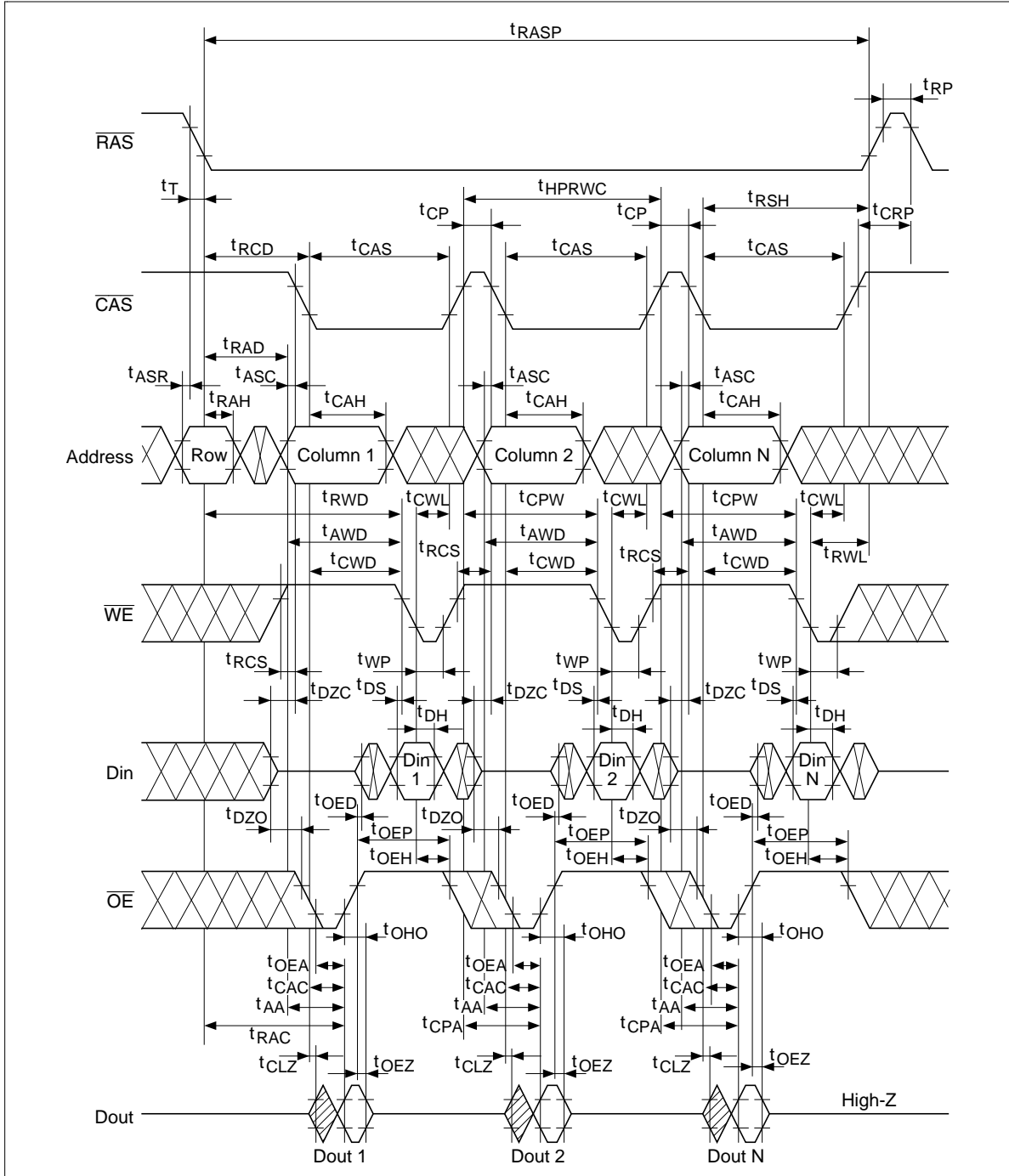
# HM5164405A Series, HM5165405A Series

## EDO Page Mode Delayed Write Cycle\*18



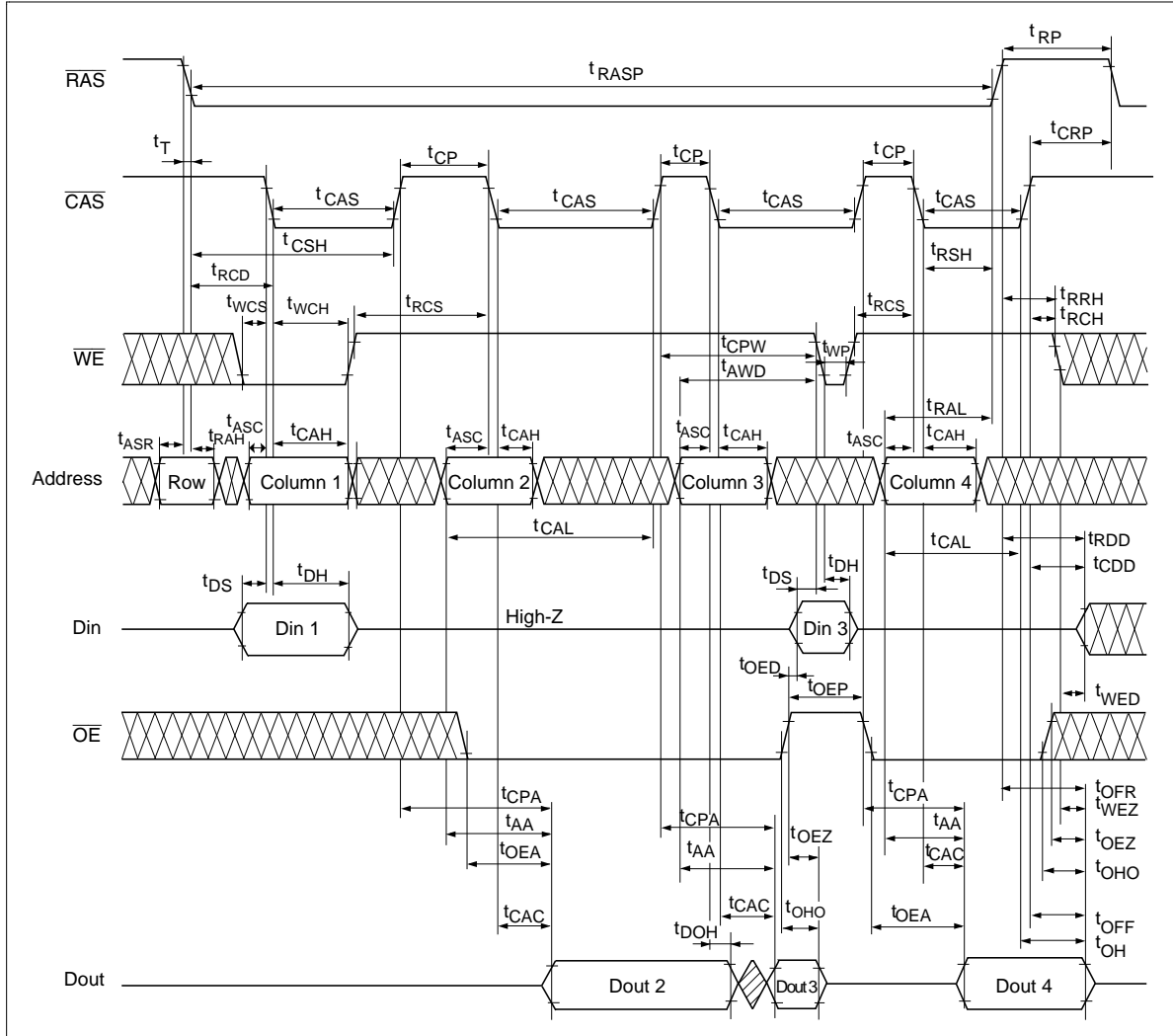
# HM5164405A Series, HM5165405A Series

## EDO Page Mode Read-Modify-Write Cycle\*18



# HM5164405A Series, HM5165405A Series

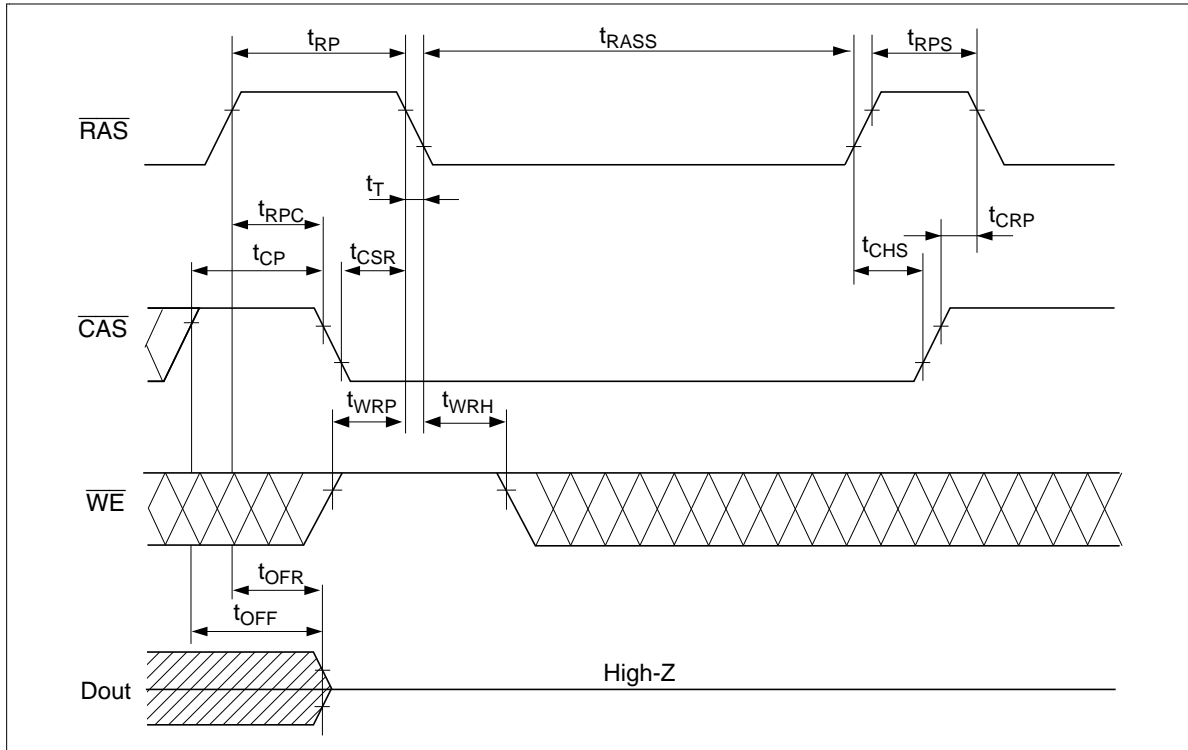
## EDO Page Mode Mix Cycle (1)\*19





# HM5164405A Series, HM5165405A Series

Self Refresh Cycle (L-version)\* 22, 23, 24



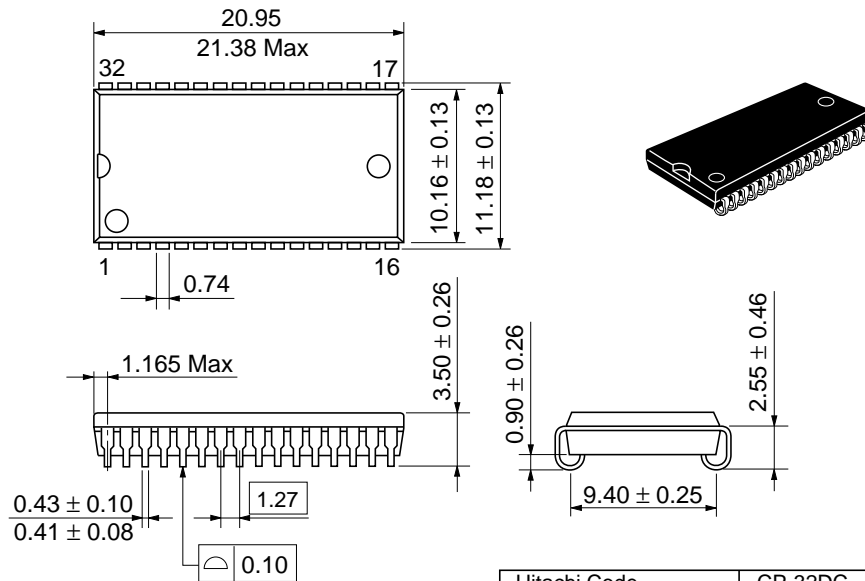
# HM5164405A Series, HM5165405A Series

## Package Dimensions

HM5164405AJ/ ALJ Series

HM5165405AJ/ ALJ Series (CP-32DC)

Unit: mm



Dimension including the plating thickness  
Base material dimension

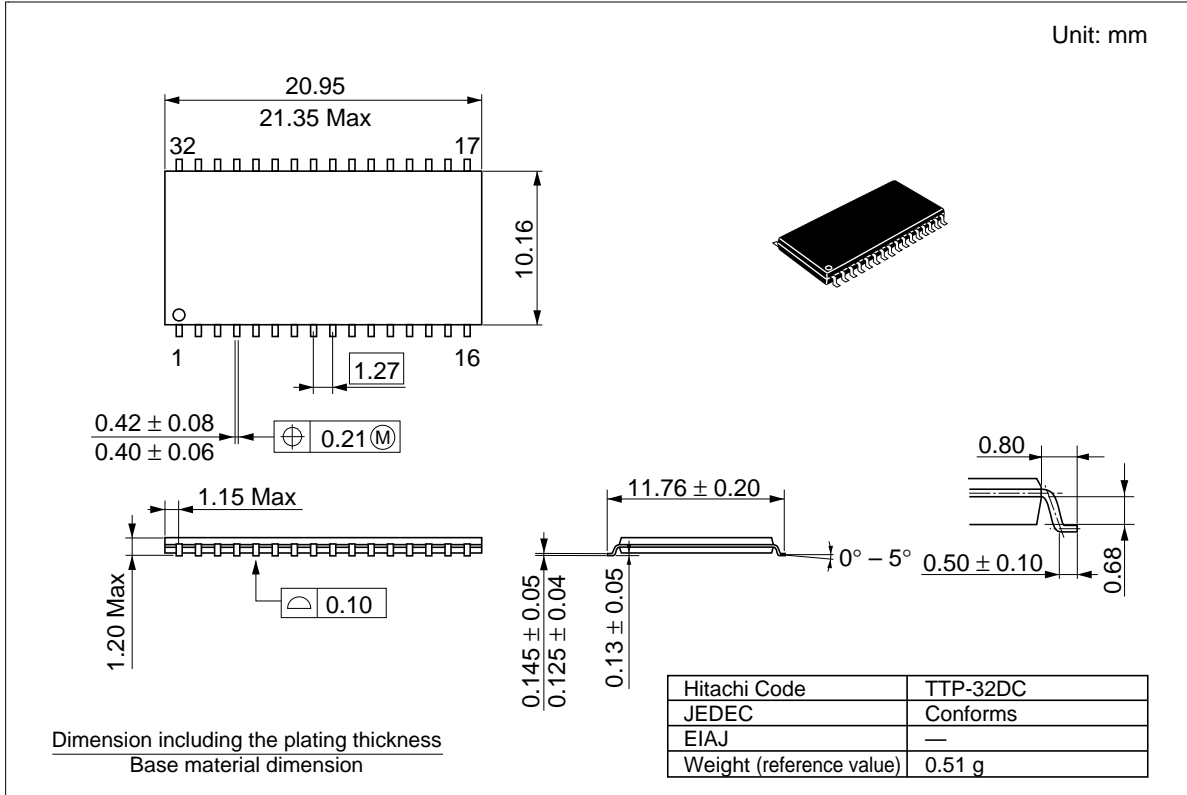
Hitachi Code	CP-32DC
JEDEC	—
EIAJ	Conforms
Weight (reference value)	1.2 g



# HM5164405A Series, HM5165405A Series

HM5164405ATT/ALTT Series

HM5165405ATT/ALTT Series (TTP-32DC)



---

## HM5164405A Series, HM5165405A Series

---

When using this document, keep the following in mind:

1. This document may, wholly or partially, be subject to change without notice.
2. All rights are reserved: No one is permitted to reproduce or duplicate, in any form, the whole or part of this document without Hitachi's permission.
3. Hitachi will not be held responsible for any damage to the user that may result from accidents or any other reasons during operation of the user's unit according to this document.
4. Circuitry and other examples described herein are meant merely to indicate the characteristics and performance of Hitachi's semiconductor products. Hitachi assumes no responsibility for any intellectual property claims or other problems that may result from applications based on the examples described herein.
5. No license is granted by implication or otherwise under any patents or other rights of any third party or Hitachi, Ltd.
6. **MEDICAL APPLICATIONS:** Hitachi's products are not authorized for use in **MEDICAL APPLICATIONS** without the written consent of the appropriate officer of Hitachi's sales company. Such use includes, but is not limited to, use in life support systems. Buyers of Hitachi's products are requested to notify the relevant Hitachi sales offices when planning to use the products in **MEDICAL APPLICATIONS**.

---

# HITACHI

## Hitachi, Ltd.

Semiconductor & IC Div.  
Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100, Japan  
Tel: Tokyo (03) 3270-2111  
Fax: (03) 3270-5109

### For further information write to:

Hitachi America, Ltd.  
Semiconductor & IC Div.  
2000 Sierra Point Parkway  
Brisbane, CA. 94005-1835  
U S A  
Tel: 415-589-8300  
Fax: 415-583-4207

Hitachi Europe GmbH  
Continental Europe  
Dornacher Straße 3  
D-85622 Feldkirchen  
München  
Tel: 089-9 91 80-0  
Fax: 089-9 29 30-00

Hitachi Europe Ltd.  
Electronic Components Div.  
Northern Europe Headquarters  
Whitebrook Park  
Lower Cookham Road  
Maidenhead  
Berkshire SL6 8YA  
United Kingdom  
Tel: 01628-585000  
Fax: 01628-585160

Hitachi Asia Pte. Ltd.  
16 Collyer Quay #20-00  
Hitachi Tower  
Singapore 049318  
Tel: 535-2100  
Fax: 535-1533

Hitachi Asia (Hong Kong) Ltd.  
Unit 706, North Tower,  
World Finance Centre,  
Harbour City, Canton Road  
Tsim Sha Tsui, Kowloon  
Hong Kong  
Tel: 27359218  
Fax: 27306071

Copyright © Hitachi, Ltd., 1997. All rights reserved. Printed in Japan.

---

## HM5164405A Series, HM5165405A Series

---

### Revision Record

Rev.	Date	Contents of Modification	Drawn by	Approved by
0.0	Oct. 13, 1995	Initial issue	S. Ikenaga	J. Kitano
0.1	Apr. 30, 1996	Change format Unification of HM5164405A Series and HM5165405A Series Addition of HM5164405A/HM5165405A-5 Series Addition of HM5164405AJ/ALJ Series, HM5165405AJ/ALJ Series (CP-32DC) Pin Descriptions Addition of Row/Refresh address and Column address to address input Addition of Block Diagrams DC Characteristics (HM5165405A) I <sub>CC1</sub> max: 140/130 mA to TBD/180/160 mA I <sub>CC3</sub> max: 120/105 mA to TBD/180/160 mA I <sub>CC6</sub> max: 120/105 mA to TBD/150/130 mA I <sub>CC7</sub> max: 120/105 mA to TBD/140/120 mA Addition of note 4 AC Characteristics t <sub>RCD</sub> max: 38/45 ns to TBD/45/52 ns t <sub>COP</sub> min: 5/5 ns to TBD/10/10 ns Addition of t <sub>WPE</sub> and t <sub>OEP</sub> t <sub>HPRWC</sub> min: 79/90 ns to TBD/68/79 ns Addition of notes 20 to 24 Change of notes 3 and 13 Timing waveforms Addition of t <sub>WPE</sub> and t <sub>OEP</sub> timings Deletion of note: t <sub>OEH</sub> ≥ t <sub>CWL</sub>	S. Ikenaga	J. Kitano
0.2	Jun. 12, 1996	AC Characteristics Change of notes 18 and 25 Timing waveforms Deletion of notes about undefined pins	S. Ikenaga	J. Kitano
0.3	Jan. 22, 1997	Power dissipation TBD/540/468 mW to TBD/396/342 mW (max) (HM5164405A Series) TBD/648/576 mW to TBD/576/504 mW (max) (HM5165405A Series)	J. Kitano	J. Kitano

---

## HM5164405A Series, HM5165405A Series

---

### Revision Record (cont)

Rev.	Date	Contents of Modification	Drawn by	Approved by
0.3	Jan. 22, 1997	DC Characteristics (HM5164405A Series) $I_{CC1}(\text{max})$ : TBD/130/110 mA to TBD/110/95 mA $I_{CC3}(\text{max})$ : TBD/130/110 mA to TBD/110/95 mA $I_{CC6}(\text{max})$ : TBD/150/130 mA to TBD/140/120 mA $I_{CC7}(\text{max})$ : TBD/140/120 mA to TBD/105/90 mA $I_{LO}$ test conditions: $0 \text{ V} \leq V_{out} \leq V_{CC} + 0.3$ to $0 \text{ V} \leq V_{out} \leq V_{CC}$  DC Characteristics (HM5165405A Series) $I_{CC1}(\text{max})$ : TBD/180/160 mA to TBD/160/140 mA $I_{CC3}(\text{max})$ : TBD/180/160 mA to TBD/160/140 mA $I_{CC6}(\text{max})$ : TBD/150/130 mA to TBD/140/120 mA $I_{CC7}(\text{max})$ : TBD/140/120 mA to TBD/120/105 mA $I_{LO}$ test conditions: $0 \text{ V} \leq V_{out} \leq V_{CC} + 0.3$ to $0 \text{ V} \leq V_{out} \leq V_{CC}$  AC Characteristics Change of note 20	J. Kitano	J. Kitano
1.0	Sep. 12, 1997	Deletion of preliminary  AC Characteristics $t_{RAD}$ (min): TBD/15/15 ns to TBD/14/15 ns $t_{RWL}$ (min): TBD/10/13 ns to TBD/15/18 ns $t_{REF}$ (L-version) (HM5164405A Series) 128 ms to TBD (for suspension of L-version),  Correct errors (HM5164405A Series) $t_{REF}$ (L-version): 4096 cycles to 8192 cycles	M. Tsunozaki	M. Saeki
2.0	Oct. 28, 1997	Deletion of HM5164405A/HM5165405A-5 Series Addition of HM5165405A-5R Addition of specification for HM5164405AL/ HM5165405AL Series  Power dissipation TBD/576/504 mW to 684/576/504 mW (HM5165405A)  Recommended DC Operating Conditions Addition of $V_{CC}$ (HM5165405A-5R): 3.15/3.3/3.6 V  DC Characteristics $I_{CC2}$ max: TBD/TBD/TBD to TBD/300/300 $\mu\text{A}$ $I_{CC10}$ max: TBD/TBD/TBD to TBD/650/650 $\mu\text{A}$ $I_{CC11}$ max: TBD/TBD/TBD to TBD/500/500 $\mu\text{A}$  AC Characteristics Test conditions Addition of output load condition (-5R): 1 TTL gate + $C_L$ (50pF) $t_{RAD}$ min: TBD/14/15 ns to 10/14/14 ns $t_{REF}$ (L-version) (8k refresh): TBD to 128 ms		

---